imall

Chipsmall Limited consists of a professional team with an average of over 10 year of expertise in the distribution of electronic components. Based in Hongkong, we have already established firm and mutual-benefit business relationships with customers from, Europe, America and south Asia, supplying obsolete and hard-to-find components to meet their specific needs.

With the principle of "Quality Parts, Customers Priority, Honest Operation, and Considerate Service", our business mainly focus on the distribution of electronic components. Line cards we deal with include Microchip, ALPS, ROHM, Xilinx, Pulse, ON, Everlight and Freescale. Main products comprise IC, Modules, Potentiometer, IC Socket, Relay, Connector. Our parts cover such applications as commercial, industrial, and automotives areas.

We are looking forward to setting up business relationship with you and hope to provide you with the best service and solution. Let us make a better world for our industry!



Contact us

Tel: +86-755-8981 8866 Fax: +86-755-8427 6832 Email & Skype: info@chipsmall.com Web: www.chipsmall.com Address: A1208, Overseas Decoration Building, #122 Zhenhua RD., Futian, Shenzhen, China





LIS2L02AQ

INERTIAL SENSOR: 2Axis - 2g/6g LINEAR ACCELEROMETER

1 FEATURES

- 2.4V TO 5.25V SINGLE SUPPLY OPERATION
- 0.5mg RESOLUTION OVER 100Hz BW
- 2g/6g USER SELECTABLE FULL-SCALE
- OUTPUT VOLTAGE, OFFSET AND SENSITIVITY RATIOMETRIC TO THE SUPPLY VOLTAGE
- FACTORY TRIMMED DEVICE SENSITIVITY AND OFFSET
- EMBEDDED SELF TEST
- HIGH SHOCK SURVIVABILITY

2 DESCRIPTION

The LIS2L02AQ is a dual-axis linear accelerometer that includes a sensing element and an IC interface able to take the information from the sensing element and to provide an analog signal to the external world.

The sensing element, capable to detect the acceleration, is manufactured using a dedicated process called THELMA (Thick Epi-Poly Layer for Microactuators and Accelerometers) developed by ST to produce inertial sensors and actuators in silicon.

The IC interface instead is manufactured using a CMOS process that allows high level of integration to design a dedicated circuit which is trimmed to better match the sensing element characteristics.

The LIS2L02AQ has a user selectable full scale of

Figure 2. Block Diagram





Table 1. Order Codes

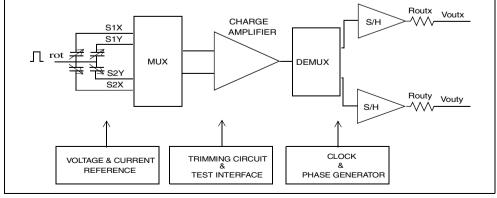
Part Number	Package
LIS2L02AQ	QFN-44

2g, 6g and it is capable of measuring accelerations over a maximum bandwidth of 4.0 KHz for both the X and Y axis. The device bandwidth may be reduced by using external capacitances. A self-test capability allows the user to check the functioning of the system.

The LIS2L02AQ is available in plastic SMD package and it is specified over a temperature range extending from -40°C to +85°C.

The LIS2L02AQ belongs to a family of products suitable for a variety of applications:

- Motion activated functions in mobile terminals
- Gaming and Virtual Reality input devices
- Virtual reality input devices
- Antitheft systems and Inertial Navigation
- Appliance Control and Robotics



N°	Pin	Function	
1 to 3	NC	Internally not connected	
4	GND	0V supply	
5	Vdd	Power supply	
6	Vouty	Output Voltage	
7	ST	Self Test (Logic 0: normal mode; Logic 1: Self-test)	
8	Voutx	Output Voltage	
9-13	NC	Internally not connected	
14	PD	Power Down (Logic 0: normal mode; Logic 1: Power-Down mode)	
15	NC	Internally not connected	
16	FS	Full Scale selection (Logic 0: 2g Full-scale; Logic 1: 6g Full-scale)	
17-18	Reserved	Leave unconnected	
19	NC	Internally not connected	
20	Reserved	Leave unconnected	
21	NC	Internally not connected	
22-23	Reserved	Leave unconnected	
24-25	NC	Internally not connected	
26	Reserved	Connect to Vdd or GND	
27	Reserved	Leave unconnected or connect to Vdd	
28	Reserved	Leave unconnected or connect to GND	
29-44	NC	Internally not connected	

Figure 3. Pin Description

Figure 4. Pin Connection (Top view)

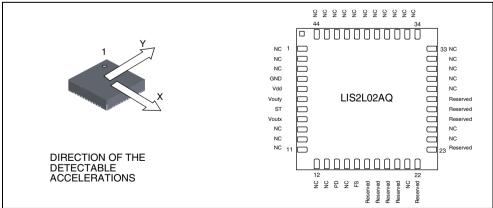


Table 2. Electrical Characteristics

(Temperature range -40°C to +85°C) All the parameters are specified @ Vdd =3.3V, T=25°C unless otherwise noted

Symbol	Parameter	Test Condition	Min.	Typ. ¹	Max.	Unit
Vdd	Supply voltage		2.4	3.3	5.25	V
ldd	Supply current	mean value PD pin connected to GND		0.85	1.5	mA
lddPdn	Supply current in Power Down Mode	rms value PD pin connected to Vdd		2	5	μA
Voff	Zero-g level ²	T = 25°C	Vdd/2-10%	Vdd/2	Vdd/2+10%	V
OffDr	Zero-g level Vs temperature	Delta from +25°C		±1.5		mg/°C
Ar	Acceleration range ³	FS pin connected to GND	±1.8	±2.0		g
		FS pin connected to Vdd	±5.4	±6.0		g
So	Sensitivity ²	Full-scale = 2g	Vdd/5-10%	Vdd/5	Vdd/5+10%	V/g
		Full-scale = 6g	Vdd/15-10%	Vdd/15	Vdd/15+10%	V/g
SoDr	Sensitivity drift Vs temperature	Delta from +25°C		±0.01		%/°C
NL	Non Linearity ⁴	Best fit straight line Full-scale = 2g X, Y axis		±0.3	±1.5	% FS
CrossAx	Cross-Axis ⁵			<u>±2</u>	±4	%
fuc	Sensing Element Resonant Frequency ⁶	X, Y axis	3.2	4.0	4.8	KHz
an	Acceleration noise density	Vdd=3.3V; Full-scale = 2g		50		μg/ √Hz
Vt	Self test output voltage delta change ^{7,8,9}	T = 25°C Vdd=3.3V Full-scale = 2g X axis	-20	40		mV
		T = 25°C Vdd=3.3V Full-scale = 2g Y axis	20	-40		mV
Vst	Self test input	Logic 0 level	0		0.8	V
		Logic 1 level	2.2		Vdd	V
Rout	Output impedance		80	110	140	kΩ

Table 2. Electrical Characteristics (continued)

(Temperature range -40°C to +85°C) All the parameters are specified @ Vdd =3.3V, T=25°C unless otherwise noted

Symbol	Parameter	Test Condition	Min.	Typ. ¹	Max.	Unit
Cload	Capacitive load drive ¹⁰		320			pF
Ton	Turn-On Time at exit from Power Down mode	Cload in μF		550*Cload +0.3		ms

Notes: 1. Typical specifications are not guaranteed

- 2. Offset and sensitivity are essentially ratiometric to supply voltage
- 3. Guaranteed by wafer level test and measurement of initial offset and sensitivity
- 4. Guaranteed by design through measurements done up to 1g
- 5. Contribution to the measuring output of the inclination/acceleration along the perpendicular axis
- 6. Guaranteed by design
- 7. Self test "output voltage delta change" is defined as Vout(Vst=Logic1)-Vout(Vst=Logic0)
- 8. Self test "output voltage delta change" varies cubically with supply voltage
- 9. When full-scale is set to 6g, self-test "output delta change" is one third of the specified value
- 10.Bandwidth=1/(2*π*110KΩ*Cload)

ABSOLUTE MAXIMUM RATING

Stresses above those listed as "absolute maximum ratings" may cause permanent damage to the device. This is a stress rating only and functional operation of the device under these conditions is not implied. Exposure to maximum rating conditions for extended periods may affect device reliability.

Symbol	Ratings	Maximum Value	Unit
Vdd	Supply voltage	-0.3 to 7	V
Vin	Input voltage on any control pin (FS, PD, ST)	-0.3 to Vdd +0.3	V
A _{POW}	Acceleration (Any axis, Powered, Vdd=3.3V)	3000g for 0.5 ms	
		10000g for 0.1 ms	
A _{UNP}	Acceleration (Any axis, Unpowered)	3000g for 0.5 ms	
		10000g for 0.1 ms	
T _{OP}	Operating Temperature Range	-40 to +85	°C
T _{STG}	Storage Temperature Range	-40 to +105	°C
ESD	Electrostatic discharge protection	2KV HBM	

Table 3. Absolute Maximum Rating

3 FUNCTIONALITY

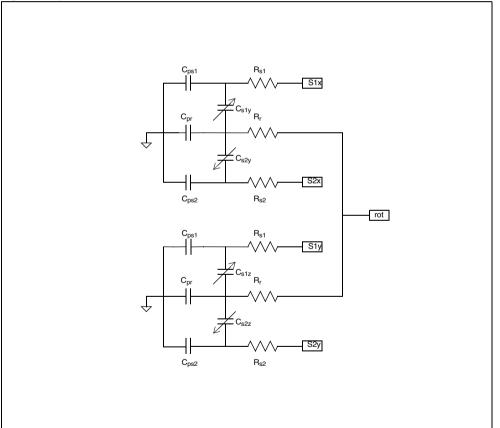
The LIS2L02AQ is a low-cost, low-power, analog output dual-axis linear accelerometer packaged in QFN package. The complete device includes a sensing element and an IC interface able to take the information from the sensing element and to provide an analog signal to the external world.

3.1 Sensing element

The THELMA process is utilized to create a surface micro-machined accelerometer. The technology allows to carry out suspended silicon structures which are attached to the substrate in a few points called anchors and free to move on a plane parallel to the substrate itself. To be compatible with the traditional packaging techniques a cap is placed on top of the sensing element to avoid blocking the moving parts during the molding phase.

The equivalent circuit for the sensing element is shown in the figure below; when a linear acceleration is applied, the proof mass displaces from its nominal position, causing an imbalance in the capacitive half-bridge. This imbalance is measured using charge integration in response to a voltage pulse applied to the sense capacitor.

Figure 5. Equivalent electrical circuit



The nominal value of the capacitors, at steady state, is few pF and when an acceleration is applied the maximum variation of the capacitive load is few hundredths of pF.

3.2 IC Interface

The complete signal processing uses a fully differential structure, while the final stage converts the differential signal into a single-ended one to be compatible with the external world.

The first stage is a low-noise capacitive amplifier that implements a Correlated Double Sampling (CDS) at its output to cancel the offset and the 1/f noise. The produced signal is then sent to two different S&Hs, one for each channel, and made available to the outside.

The low noise input amplifier operates at 200 kHz while the two S&Hs operate at a sampling frequency of 66 kHz. This allows a large oversampling ratio, which leads to in-band noise reduction and to an accurate output waveform.

All the analog parameters (output offset voltage and sensitivity) are ratiometric to the voltage supply. Increasing or decreasing the voltage supply, the sensitivity and the offset will increase or decrease linearly. The feature provides the cancellation of the error related to the voltage supply along an analog to digital conversion chain.

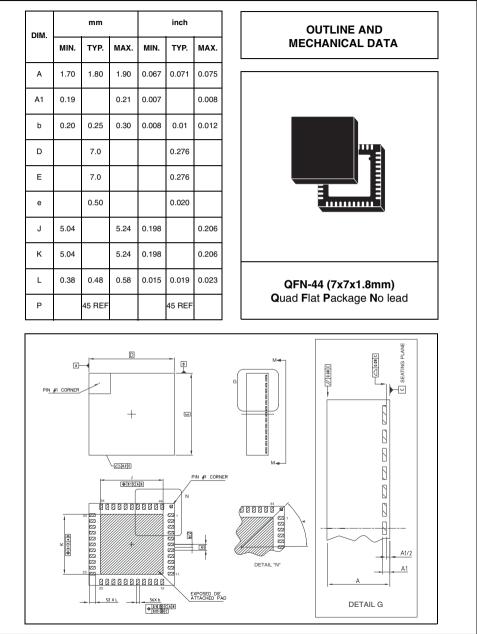
3.3 Factory calibration

The IC interface is factory calibrated to provide to the final user a device ready to operate.

The trimming values are stored inside the device by a non volatile structure. Any time the device is turned on, the trimming parameters are downloaded into the registers to be employed during the normal operation thus allowing the final user to utilize the device without any need for further calibration.

4 PACKAGE INFORMATION

Figure 6. QFN-44 Mechanical Data & Package Dimensions



57

Table 4. Revision History

Date	Revision	Description of Changes
January 2004	1	First Issue
February 2004	2	Values of some parameters have been changed in Electrical characteristics table.
November 2004	3	Changed the maturity from Product Preview to Final. Modified/added some values in the table 2 Electrical characteristics.

Information furnished is believed to be accurate and reliable. However, STMicroelectronics assumes no responsibility for the consequences of use of such information nor for any infringement of patents or other rights of third parties which may result from its use. No license is granted by implication or otherwise under any patent or patent rights of STMicroelectronics. Specifications mentioned in this publication are subject to change without notice. This publication supersedes and replaces all information previously supplied. STMicroelectronics products are not authorized for use as critical components in life support devices or systems without express written approval of STMicroelectronics.

> The ST logo is a registered trademark of STMicroelectronics. All other names are the property of their respective owners

> > © 2004 STMicroelectronics - All rights reserved

STMicroelectronics group of companies

Australia - Belgium - Brazil - Canada - China - Czech Republic - Finland - France - Germany - Hong Kong - India - Israel - Italy - Japan -Malaysia - Malta - Morocco - Singapore - Spain - Sweden - Switzerland - United Kingdom - United States of America www.st.com